

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination VERWEG ET AL.	
			Examiner Abiy Getachew	Art Unit 2841	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,440,452	08-1995	Kitahara, Akira	361/773
*	B	US-2005/0142917 A1	06-2005	Verweg et al.	439/212
*	C	US-2005/0237424 A1	10-2005	Weekamp et al.	348/373
*	D	US-6,486,412 B2	11-2002	Kato, Hiroki	174/260
*	E	US-7,078,788 B2	07-2006	Vu et al.	257/668
*	F	US-7,067,356 B2	06-2006	Towle et al.	438/122
*	G	US-7,053,381 B2	05-2006	Shaw et al.	250/370.11
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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